

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10537306	BRIQUE ET AL.
	Examiner	Art Unit
	SHIN-HON CHEN	2131

SEARCHED

Class	Subclass	Date	Examiner
380	231,239	7/5/07	S.C.
713	193	7/5/07	S.C.

SEARCH NOTES

Search Notes	Date	Examiner
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search - see search history)	7/5/07	S.C.
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search - updated search)	8/2/08	S.C.

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner